Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/803,795	HAYASHI ET AL.	
Examiner	Art Unit	
Jason M. Han	2875	

	SEAR	CHED	
Class	Subclass	Date	Examiner
362	460	12/12/2005	ЈМН
362	464-467	12/12/2005	ЈМН
362	523	12/12/2005	JMH
362	525	12/12/2005	ЈМН
315	82	12/12/2005	ЈМН

ראו	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search History - EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, DERWENT) - See Printout	12/12/2005	ЈМН		
P.E. Stephen Husar	12/12/2005	JMH		
Inventor Search	12/12/2005	JMH		